

SLEW RATE CONTROL OF OUTPUT DRIVERS USING FETS WITH DIFFERENT THRESHOLD VOLTAGES

Field of the Invention

5 The present invention relates generally to integrated circuit pad circuits, and more particularly to controlling the slew rate of output drivers using transistors with differing threshold voltages.

Background of the Invention

10 Integrated circuits communicate with one another using digital signals. In the digital world, a digital signal may be in one of a plurality of predefined quantized states. Because digital signals are transmitted using an analog signal along a transmission line, the predefined quantized states of the digital signal are represented by different ranges of voltages within the total voltage range of the signal. For example, a typical digital integrated circuit (IC) will communicate using two states - zero and one. The digital state of zero is represented by the range of voltages between a minimum voltage V_{MIN} (e.g., 0 volts) of the potential voltage range of the signal and a voltage V_{LOW} that is low relative to the total range of voltage, whereas the digital state of one is represented by the range of voltages between a voltage V_{HIGH} that is high relative to the total range of voltages and a maximum voltage V_{MAX} (e.g., 1.5 volts) of the potential voltage range of the signal. In this example, the state of the digital signal is unknown when the voltage level of the signal is between V_{LOW} and V_{HIGH} , which typically only occurs during transitions of the signal from either the zero state to the one state or vice versa.

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 Because the transmission signal is actually analog, the transition between digital states does not occur instantaneously, but instead occurs over a period of time $T_{\text{TRANSITION}}$ that is dependent on the physical conditions present on the transmission line. It is well known that signal transitions over a transmission line will suffer a delay known as a propagation delay due to the parasitic resistance, inductance, and capacitance of the line. This delay increases with the length of the line. In addition, it is also well-known that

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Brief Description of the Drawing

The invention will be better understood from a reading of the following detailed description taken in conjunction with the drawing in which like reference designators are used to designate like elements, and in which:

5 FIG. 1A is an operational flowchart of a method for adjusting the amount of current conducted to the output pad in order to slow down the edge rate of the signal on the output pad by incrementally increasing the amount of current conducted to the output pad;

 FIG. 1B is an operational flowchart of a method for adjusting the
10 amount of current conducted to the output pad by incrementally decreasing the amount of current conducted to the output pad;

 FIG. 2 is a schematic diagram of a slew-rate controlled output driver circuit implemented in accordance with the invention;

 FIG. 3A is a voltage-vs.-timing diagram illustrating a driving voltage
15 signal;

 FIG. 3B is a voltage-vs.-timing diagram illustrating the output signal seen on the output pad as a result of the driving voltage signal of FIG. 3A;

 FIG. 4 is an alternative embodiment of a slew rate controlled output driver circuit implemented in accordance with the invention;

20 FIG. 5 is an operational flowchart of an exemplary embodiment of a method in accordance with the invention for implementing a circuit for controlling the slew rate of output drivers by using transistors with differing threshold voltages to achieve a stepped-stage slew rate on the edges of the signal transitions; and

25 FIG. 6 is an operational flowchart of a method for operating a circuit built in accordance with FIG. 5.

Detailed Description

30 A novel method and circuits for controlling the slew rate of output drivers using transistors with differing threshold voltages is described in detail hereinafter. Although the invention is described in terms of specific illustrative embodiments, such as specific output driver designs, it is to be understood that the embodiments described herein are by way of example

only and the scope of the invention is not intended to be limited thereby but is intended to extend to any embodiment incorporating any number of transistors of any type with differing threshold voltages that results in stepped-stage slew rate on the edges of signal transitions.

5 Turning now in detail to the drawing, FIGS. 1A and 1B illustrate an exemplary embodiment of methods in accordance with the invention for controlling the slew rate of output drivers by using transistors with differing threshold voltages to achieve a stepped-stage slew rate on the edges of the signal transitions. In particular, the invention employs switchably conductive
10 devices such as field effect transistors (FETs) with varying threshold voltages. It is known in the art that FETs may be designed with varying specifications. For example, the FETs most commonly used in integrated circuits due to their lower voltage ratings have a threshold voltage between 0.4-0.5 volts. FETs designed for use in higher power applications typically
15 have a threshold voltage between 0.6 and 0.7 volts. This 200-300 mV difference is used to advantage in the present invention to achieve a stepped-stage slew rate on the signal edges as discussed hereinafter.

FIG. 1A illustrates a method 10 for adjusting the amount of current conducted to the output pad in order to slow down the edge rate of the signal
20 on the output pad by incrementally increasing the amount of current conducted to the output pad. As shown in FIG. 1A, the driving voltage, which controls the amount of current to conduct to the output pad, is sensed 12. When the driving voltage reaches a first threshold, for example voltage corresponding to the lowest threshold voltage of all conductive devices
25 coupled to the output pad, as determined in step 14, the amount of current conducted to the pad is stepped up 16, for example from no current conduction to a first increment of conduction. When the driving voltage reaches a next threshold, for example voltage corresponding to the next highest threshold voltage of all conductive devices coupled to the output
30 pad, as determined in step 18, the amount of current conducted to the pad is stepped up 20 to a higher level. Steps 18 and 20 may be repeated for additional higher threshold voltage levels of additional conductive devices coupled to the output pad.

FIG. 1B illustrates a method 30 for adjusting the amount of current conducted to the output pad in order to slow down the edge rate of the signal on the output pad by incrementally decreasing the amount of current conducted to the output pad. As shown in FIG. 1B, the driving voltage, which controls the amount of current to conduct to the output pad, is sensed 32. When the driving voltage reaches a first threshold, for example voltage corresponding to the highest threshold voltage of all conductive devices coupled to the output pad, as determined in step 34, the amount of current conducted to the pad is stepped down 36, for example from maximum current conduction to a smaller amount of conduction. When the driving voltage reaches a next threshold, for example voltage corresponding to the next lowest threshold voltage of all conductive devices coupled to the output pad, as determined in step 38, the amount of current conducted to the pad is stepped down 40 to a lower level. Steps 38 and 40 may be repeated for additional lower threshold voltage levels of additional conductive devices coupled to the output pad.

As will become apparent in the description hereinafter, the two methods 10 and 30 may alternatively operate to drive a single data signal.

Turning now to a specific preferred embodiment, FIG. 2 depicts a slew rate controlled output driver circuit 100 in accordance with the present invention. As will be described in detail hereinafter, the slew-rate controlled output driver circuit 100 of FIG. 2 provides the functionality for controlling the slew rate of the signal driven onto the output pad by performing a step-controlled edge transition.

As known in the art, a typical output driver will include at least an inverter 110 having an input coupled to receive a data signal and an output coupled to the gate of a transistor whose drain is coupled to an output pad 150 and whose source is coupled to either a high voltage source (e.g., V_{DD}) for driving the output pad to a high voltage level, or a low voltage source (e.g., V_{SS} or ground) for driving the output pad to a low voltage level. In the illustrative embodiment of FIG. 2, the circuitry is implemented using field effect transistors (FETs). Furthermore, the output driver 100 includes two stages: drive high stage S1 and drive low stage S2.

As shown, drive high stage S1 includes a first inverter 110 which receives data signal DATA. The output of the inverter is connected to the gate of a low-voltage p-channel FET (PFET) P_{LV} and to the gate of a high-voltage PFET P_{HV} . The sources of PFETs P_{LV} and P_{HV} are each connected to the circuit high-voltage source V_{DD} , and their drains are each connected to the pad node 150.

Drive low stage S2 includes a second inverter 120 which also receives data signal DATA. The output of the inverter is connected to the gate of a low-voltage n-channel FET (NFET) N_{LV} and to the gate of a low-voltage NFET N_{HV} . The sources of NFETs N_{LV} and N_{HV} are each connected to the circuit ground, and their drains are each connected to the pad node 150.

Referring now also to FIGS. 3A and 3B in conjunction with FIG. 2, in operation, when the data signal DATA transitions from a low to a high voltage level, inverters 110 and 120 will both output a low voltage level. Accordingly, a low voltage level is applied to the gates of PFETs P_{LV} and P_{HV} , turning them both on, in a staged manner, to source a high-voltage level V_{DD} onto the pad node 150. Because low-voltage PFET P_{LV} is characterized by a lower threshold voltage than high-voltage PFET P_{HV} , PFET P_{LV} will turn on sooner than PFET P_{HV} , as illustrated at P_{LV_ON} and P_{HV_ON} in FIG. 3A. Since PFETs P_{LV} and P_{HV} operate as resistors coupled in parallel, the voltage level on the output pad, shown in FIG. 3B, transitions more slowly during the period of time when only the low-voltage PFET is on, and more quickly when the high-voltage PFET turns on. Accordingly, the addition of the high-voltage PFET P_{HV} in parallel with the low-voltage PFET P_{LV} allows a stepped-stage slew rate of the edge transition, where the slew rate of each stage is controlled by the sizing of the low- and high-voltage PFETs P_{LV} and P_{HV} .

Whenever the data signal DATA is high, resulting in a low voltage level output by inverters 110 and 120 and the application of a low voltage level to the gates 112 and 132 of PFETs P_{LV} and P_{HV} , a low voltage level is simultaneously applied to the gates 122 and 142 of NFETs N_{LV} and N_{HV} . The application of the low voltage levels to the gates 122 and 142 of NFETs

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N_{LV} and N_{HV} turns off NFETs N_{LV} and N_{HV} to isolate the pad node 150 from ground when the pad is being driven high. Because low-voltage NFET P_{LV} is characterized by a lower threshold voltage than high-voltage NFET P_{HV} , high-voltage NFET N_{HV} will turn off sooner than low-voltage NFET N_{LV} , as illustrated at N_{LV_ON} and N_{HV_ON} in FIG. 3A. Just as in the case of the high-voltage PFETs P_{LV} and P_{HV} , low-voltage NFETs N_{LV} and N_{HV} operate together as resistors coupled in parallel. Accordingly, the voltage level on the output pad 150 (shown in FIG. 3B) transitions more quickly during the period of time when both the high- and low-voltage NFETs N_{HV} and N_{LV} are on and more slowly when only the low-voltage NFET N_{LV} is on. Accordingly, the use of the high-voltage NFET N_{HV} in parallel with the low-voltage NFET N_{LV} results in a stepped-stage slew rate of the edge transition, where the slew rate of each transition stage is controlled by the sizing of the low- and high-voltage NFETs N_{LV} and N_{HV} (together with the sizing of the low- and high-voltage PFETs P_{LV} and P_{HV}).

When the data signal DATA transitions to a low voltage level, inverters 110 and 120 will both output a high voltage level. Accordingly, a high voltage level is applied by inverter 110 to the gates of PFETs P_{LV} and P_{HV} , turning them both off, in a staged manner, to isolate the high-voltage level VDD from the pad node 150. Again, because low-voltage PFET P_{LV} is characterized by a lower threshold voltage than high-voltage PFET P_{HV} , PFET P_{HV} will turn off sooner than PFET P_{LV} , resulting in a stepped-stage slew rate of the edge transition as shown in FIGS. 3A and 3B.

Simultaneously, the high voltage level output by inverter 120 is applied to the gates 122 and 142 of NFETs N_{LV} and N_{HV} . The application of the high voltage level to the gates 122 and 142 of NFETs N_{LV} and N_{HV} turns on NFETs N_{LV} and N_{HV} to pull the pad node 150 to ground in a stepped-stage manner due to the difference in threshold voltages of low-voltage NFET P_{LV} and high-voltage NFET P_{HV} . In particular, the voltage level on the output pad 150 transitions to ground more quickly when both the high- and low-voltage NFETs N_{HV} and N_{LV} are on and more slowly when only the low-voltage NFET N_{LV} is on.

FIG. 3B shows the output signal PAD seen on pad node 150 with and without the invention. As shown, in the prior art, without the additional high-voltage transistors P_{HV} and N_{HV} of the invention, the output signal edge transitioned fully once the threshold voltage of the respective transistors was reached (as limited by the size (i.e., resistance) of the transistor). By staging the transition using transistors with different threshold voltages, the edge transition can be slowed down by essentially delaying the full transition.

It will be appreciated that the number of transistors with differing threshold voltages and connected as shown at 130 and 140 in FIG. 2 can be increased to add further stepped stages, and therefore additional control, of the edge transitions of the signal.

FIG. 4 is an alternative embodiment of a slew rate controlled output driver circuit 200 in accordance with the invention. In this embodiment, output driver 200 includes an inverter 210 which receives data signal DATA. The output of the inverter is connected to the gate of a low-voltage NFET $N2_{LV}$ and to the gate of a high-voltage NFET $N2_{HV}$. The sources of NFETs $N2_{LV}$ and $N2_{HV}$ are each connected to the circuit ground, and their drains are each connected to the pad node 250. A pullup resistor 220 is connected between the pad node 250 and a high-voltage source V_{DD} .

In operation, when the input signal DATA is low, the pad is to be driven low, and the signal is high, the pad is to be driven high. When the input signal DATA undergoes a high-to-low transition, the output of the inverter 210 transitions from low-to-high, and accordingly, a low-to-high transition is applied to the gates of low- and high-voltage NFETs $N2_{LV}$ and $N2_{HV}$, whereby both of them eventually fully conduct and pull the output pad 230 to ground. When the input signal DATA undergoes a low-to-high transition, the output of the inverter 210 transitions from high-to-low, which is applied to the gates of low- and high-voltage NFETs $N2_{LV}$ and $N2_{HV}$, whereby both of them eventually are turned off to isolate the output pad 230 from ground, allowing pull-up resistor 220 to pull the output pad 230 to V_{DD} . The use of parallel low- and high-voltage transistors results in a staged level of conductance similar to the timing diagram of FIG. 3A and 3B.

FIG. 5 illustrates an exemplary embodiment of a method 50 in accordance with the invention for implementing a circuit for controlling the slew rate of output drivers by using transistors with differing threshold voltages to achieve a stepped-stage slew rate on the edges of the signal transitions. As illustrated, in accordance with the method 50, a first switchably conductive device characterized by a first threshold voltage and having a switch control connected to a driving voltage is connected 52 between the output pad node and a source. A second or more switchably conductive device each characterized by a different threshold voltage and having a switch control connected 54 to the driving voltage is connected in parallel with the first switchably conductive device between the output pad node and a source. A driving voltage is connected 56 to each of the control switches of the first and second or more switchably conductive devices.

FIG. 6 illustrates a method 60 of operation of a circuit built in accordance with FIG. 5. As illustrated, the driving voltage driving the switch control of the first and second or more switchably conductive devices is monitored 62. When the driving voltage transitions 64 in a first direction to reach 66 the first threshold voltage, the first switchably conductive device is turned on 68. When the driving voltage reaches 70 the next higher threshold voltage of the devices, the switchably conductive device associated with the next higher threshold voltage is turned on 72. Steps 70 and 72 are repeated for each additional switchably conductive device. When the driving voltage transitions in a second direction to reach 74 the second or highest threshold voltage, the second or associated switchably conductive device is turned off 76. When the driving voltage continues in the second direction and reaches 78 the first or next lowest threshold voltage, the first or associated switchably conductive devices is also turned off 80. Steps 78 and 80 are repeated for each additional switchably conductive device.

While illustrative and presently preferred embodiments of the invention have been described in detail herein, it is to be understood that the inventive concepts may be otherwise variously embodied and employed and that the appended claims are intended to be construed to include such variations except insofar as limited by the prior art.